

Another EMC resource from EMC Standards

Tutorial on EMC for Functional Safety



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Contents of this module

- 1. Special EMC tests are required for safety
- 2. Two reasons for EMC verification testing
- 3. Verifying EMC of design aspects
- 4. Combining physical stress testing with EMC
- 5. Radiated and conducted immunity tests
- 6. Dealing with multiple simultaneous EM threats
- 7. EMC testing the finished equipment
- 8. Some useful testing references

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Special EMC tests are required for safety-related equipment

- No practical tests on the finished equipment can give a high degree of confidence in its EM performance over its entire lifetime
 - because such testing would take *much* too long
 - ◆ just as it would take much too long to fully test software
- So, just as for safety-related software...
 - we must use good EMC design methods, verified as far as possible by appropriately designed EMC tests
 - these EMC tests and test plans individually designed by EMC-for-functional-safety experts, for each project

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Two reasons for EMC testing

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- 1 To verify that all critical EM design aspects will maintain the necessary EM performance over their equipment's lifecycle
 - despite the effects of the real physical environment
- 2 To verify that the finished equipment's EM performance meets its EMC specification
 - EMC tests might not be needed when a performance aspect is guaranteed by design (or by design tests)
 - ◆as long as the QC ensures the correct build state

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An example

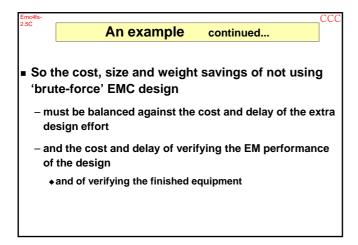
- It is possible to use highly-shielded cabinets...
 - with anti-vibration, temperature control, etc., if required
 - and flexible shielded conduit for all cabling...
 - and just one 'MIL-Spec' mains filter / surge suppresser...
- To almost guarantee adequate EM performance even in the most severe EM environments
 - without any EMC testing of the final equipment
 - based solely on calculations, test results and QC for its component parts...
 - ◆plus good EMC design, assembly and installation practices

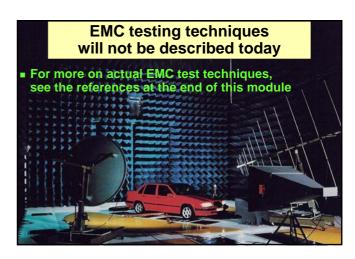
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An example

continued...

- Manufacturers who want to minimise the cost, size, or weight of their equipment...
 - don't like to use such 'brute-force' military-style EMC design techniques
- But if they do not use such techniques
 - then the arguments for EMC testing the finished equipment become stronger
 - especially for high SILs (or SIL-capabilities)



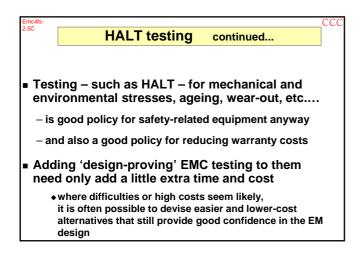


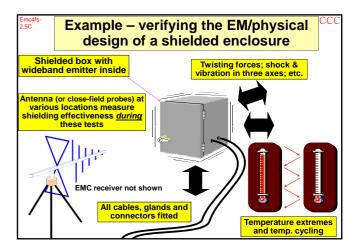
Verifying the EM performance of aspects of the design

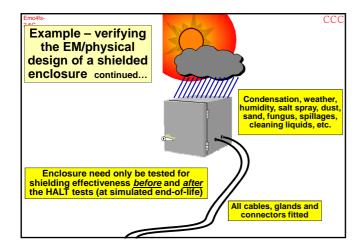
- Verifying the EM performance of all the EMC-critical (at least) design aspects...
 - for the equipment's foreseeable physical, environmental, and electromagnetic stresses...
 - helps to prove good EMC design practices quickly at lowest-cost
 - and makes the achievement of lifetime EMC possible
- This requires EMC testing during physical stress tests of the design aspects (and after 'ageing' them)

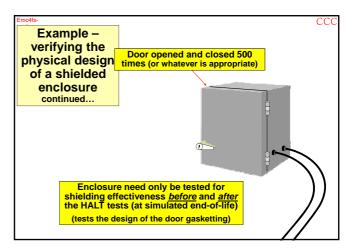
"HALT" stress testing "HALT" stress testing HALT = highly accelerated life testing - test to find weaknesses in the design, and the operational limits of the equipment - best done on 'risky' design elements early in a project +e.g. design of shielding of modules, units and cabinets; filters; surge protectors; sub-assemblies; etc. HALT tests are designed individually by mechanical and environmental experts +so that they are realistic for the equipment's type of

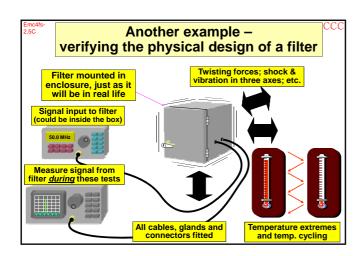
construction and intended use

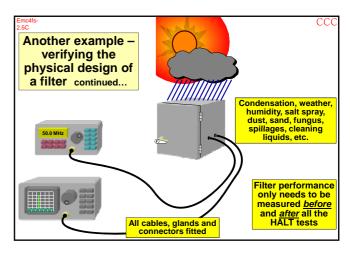


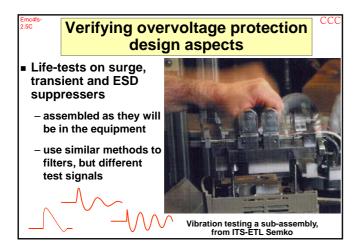












Verifying electromechanical design aspects ■ Shock and vibration tests on mounted devices can quickly reveal problems due to 'chattering' ■ Supply dips and dropouts are more likely to cause misoperation during shock and vibration — calculations might show the chances of simultaneous occurrence is low enough not to bother testing this ■ Supply dips and dropouts are more likely to cause misoperation at higher temperatures (easily tested) — and with aged devices (requires HALT type tests)

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Verifying electromechanical design aspects continued...

- Contact welding due to surge currents is unlikely to be affected by mechanical forces or environmental conditions
 - but the operation of positively-guided contacts might be



Some 'contactor relays' from Moeller

Verifying the design of electronics and/or software

- These can be susceptible to subtle aspects of their EM environment
 - e.g. the type of modulation used by a radio transmission
 - or the frequency spacings between two or more radio channels (rather than simply the strength of the radio frequency field)
 - e.g. the voltage and current waveshapes of a transient
 - ◆rather than simply its peak overvoltage level

Verifying the design of electronics and/or software

- So electronics and software need to use more sophisticated EMC tests
 - to verify the lifecycle reliability of their physical realisations

Continuous immunity testing

- Equipment is especially susceptible at the operating frequencies of its internal hardware and software processes...
 - as described in the previous section on 'Mitigation'
- But high-enough levels of interfering signals can overdrive devices...
 - causing errors, malfunctions, maybe even damage...
 - at any frequency

Continuous immunity testing continued...

- So we test with carrier waves that cover <u>all</u> of the frequencies that could reasonably foreseeably exist in the operating environment over the lifetime
 - with unmodulated CW as well as with modulation at the EUT's 'especially susceptible frequencies'
- The typical result is that from 0 to 150kHz we test with CW signals plus a pulse OFF then ON again
 - and at each tested frequency above 150kHz the test signal is a CW period followed by 'chirp modulation' over the range of 'especially susceptible frequencies' below 30kHz, then pulsed OFF for a time then back ON again

CCCC Continuous immunity testing continued...

- The 'CW, chirp and OFF/ON pulse' must be slow enough to be sure of detecting any errors, malfunctions or damage in the functions being tested
 - if necessary, time may be able to be saved by monitoring critical electronic circuits within the EUT
 - special probes with high levels of immunity are available for monitoring, but are not always required

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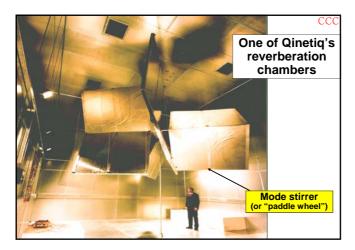
Continuous immunity testing continued...

- If the 'especially susceptible frequencies' have previously been identified (see the previous section on 'Mitigation')...
 - the testing time may be able to be reduced by modulating only at those frequencies, instead of a full chirp
- Where exposure to pulsed sources is possible (e.g. radars, pulse weapons, etc.)
 - their relevant frequency range should be covered using appropriate pulse modulation waveforms...
 - +especially any waveforms with a frequency content that

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Radiated immunity testing

- Anechoic testing is unlike most real-life EM environments, so Reverberation Chamber methods have been developed to give more confidence
 - their results can be correlated mathematically with the reflectivity of the operational EM environment
- Reverb chambers and their RF power amplifiers cost a great deal less than anechoic chambers
 - and they can be very large, and thorough testing can take less time than anechoic
 - ♦ because there is no need to test with many angles, and with vertical and horizontal antenna polarisations



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An example of the 'reverberation chamber' test method

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- The stirrer rotates over a full revolution, in a series of steps (usually between 20 and 120)
 - at each step, radio fields are generated in the chamber
 - comparable in frequency range and magnitude with the foreseeable radiated threats
- The frequency range is covered in small steps (sometimes as small as 0.1%)
 - at each step the radio field is modulated with the appropriate 'CW, chirp plus OFF/ON pulse'
 - at the appropriate rate (related to the time-constant of the function being tested)

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Conducted immunity testing

- Where equipment is too large, or frequencies too low, radiated testing can be costly or impractical...
 - so alternative conducted coupling test techniques have been developed
 - these should use the methods described in the latest versions of DO160 (or IEC 61000-4-6)
 - using the 'CW, chirp + OFF/ON pulse' modulation at the appropriate RF test frequencies
 - at a slow enough rate to detect errors or malfunctions in the tested functions

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Conducted immunity testing

continued...

- But conducted testing of each cable is not a true alternative to radiated testing at lower frequencies
- So it may be more realistic to use striplines, TEM cells, Helmholtz coils...
 - or other E and H field immunity tests
 (e.g. from military or aerospace immunity standards)
 - as before, using the 'CW, chirp + OFF/ON pulse' modulation at the appropriate RF test frequencies, at a slow enough rate to detect errors or malfunctions in the tested functions

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It is difficult to do radiated immunity tests <u>during</u> HALT (or similar)

- But it is feasible to do conducted immunity tests
 - which can be extended to 1GHz to help identify problems that could compromise radiated immunity

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Sometimes it is not necessary to combine HALT (or similar) with EMC tests

- Where a design aspect can be shown by analysis, calculation or calibrated computer simulation to maintain its EM performance...
 - despite foreseeable shock, vibration, spray, mould growth, condensation, temperature, wear, ageing, etc...
 - or has already been proven by appropriate testing or fulllifecycle experience in a very similar application
 - then a case may be made for not doing EMC testing during HALT tests
 - on that design aspect

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Dealing with multiple simultaneous EM threats

- Where each individual threat affects a particular circuit or unit in exactly the same way
 - the worst-case is to assume their effects are additive
- Then, for continuous threats (e.g. radio transmissions on a number of frequencies)...
 - or for continuous threats plus one transient threat...
 - test with each threat in turn at a level equivalent to the combined threat
 - ◆ requires calculations

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Where significant intermodulation possibilities remain in the final design...

- The EUT should be tested with the full range of frequencies that it can experience
 - modulating them with the 'especially susceptible frequencies' to simulate the results of intermodulation
 - ◆even if the threats at those RF frequencies would not normally be modulated in such a way
- Alternatively, monitoring points within the EUT to see if the IM products will be negligible enough

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Where significant intermodulation possibilities remain in the final design...

- But where these techniques still leave an untested area, testing with simultaneous RF frequencies might be required
 - it might be possible to test with simultaneous frequencies at lower levels than real life...
 - measuring and analysing the results for the susceptible circuits (e.g. using 'calibrated' analysis techniques)
 - hopefully avoiding the need for full-power intermodulation testing

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Other testing issues

 Tests should be carried out at the maximum level expected over the lifecycle...

- ◆increased as described earlier to allow for uncertainties
- and also tested at lower levels (because the devices have non-linear behaviour, so lower might be worse)
 - ◆for both transient and continuous threats
- All transient tests should be carried out often enough to be sure to coincide with vulnerable software states
 - and to confirm the ratings of the protection devices

Where each EM threat causes a different error or malfunction...

- <u>And</u> where those errors or malfunctions <u>could not</u> <u>possibly</u> affect the same safety functions...
 - e.g. a machine starting up when supposed to be in standby, plus a failure in the guarding circuit that prevents access to the machine
 - real-life example of a packaging machine that, after lightning struck the building it was in, ran at full speed backwards with all of its guards open
 - then it is probably enough to test with each EM threat individually, at the specified level

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Where each EM threat causes a different error or malfunction... continued...

- But where these errors or malfunctions <u>could</u> <u>possibly</u> affect the same safety function(s)
 - ◆e.g. an overspeed, plus failure of the overspeed detector
 - then it may be necessary to test a number of times, with one problem permanently simulated each time

The designer should be able to show that there is no point in EMC testing the finished equipment

- because he/she has already proven that the EMC design aspects will reliably protect the equipment from its foreseeable EM environment...
- over its foreseeable lifecycle



HMS Sheffield on fire during the Falklands war Poor EMC was a major cause of this disaster

But EMC testing of the final equipment is <u>always</u> required

- At least using pristine equipment in a benign environment
 - testing after HALT is better, and may be necessary
 - the EMC procedures and test methods used for safety-related equipment should be similar to those described earlier



EMC testing a refurbished self=propelled gun, at ABRO, Bovington

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Final EMC testing should...

- be performed at the highest practical level of assembly
 - ◆e.g. on-site testing of systems and installations
- replicate, as far as possible, the foreseeable EM environment
- operate the equipment as it will be in real life
- with all performance degradations detected and assessed from the point of view of functional safety
 - or reliability or measurement accuracy, where they are the main concern

EMC Testing for Functional Safety the end Cherry Clough www.cherryclough.com Eur Ing Keith Armstrong CEng MIEE MIEEE ACGI phone: +44 (0)1457 871 605 fax: +44 (0)1457 820 145 keith.armstrong@cherryclough.com

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Some EMC testing references

- On-Site Testing Methods, Keith Armstrong, downloadable from the "Publications and Downloads" page at http://www.cherryclough.com
 - Note: this was written to help with EMC Directive compliance, not for safety purposes
- Directivity of Equipment and its Effect on Testing in Mode-Stirred and Jansson, L., and M. Bäckström, IEEE International Symposium on EMC. Seattle, August 99
- An Introduction to Reverberation Chambers for Radiated Emission/Immunity Testing, Freyer, G.J., and Hatfield, M.O., ITEM 1998, www.rbitem.com
- Coupling to Devices in Electrically Large Cavities, or Why Classical EMC Evaluation Techniques are Becoming Obsolete, John Ladbury, IEEE International Symposium on EMC, Minneapolis, Aug 02

Some EMC testing references continued.

- Low Level Coupling Techniques for the HIRF Clearance of Air Systems, A Wraight et al, EMC-Europe 04, Eindhoven, Sep 6-10, pp 776-780, ISBN: 90-6144-990-1
- The Case for Combining EMC and Environmental Testing, William H Parker, Wayne Tustin, Tony Masone, ITEM 2002 pp 54-59, www.rbitem.com
- REO booklets on EM Phenomena and EN Test Methods free from http://www.reo.co.uk
 - as well as describing how to perform tests to the IEC/EN basic EMC test methods, these booklets describe the various types of EM disturbances, where they might occur, their possible magnitudes, and what effects they might have on electrical and electronic equipment

Some EMC testing references continued..

RTCA/DO-160E Civil aerospace EMC standards, from www.rtca.org

- DEF STAN 59-41, from www.dstan.mod.uk/home.htm
- MIL STD 461E, ask Google for sources
- ITU 'K' Recommendations on 'resistibility' and immunity, International Telecommunications Union, www.itu.org
- GR-1089-CORE Electromagnetic Compatibility and Electrical Safety - Generic Criteria for Network Telecommunication Equipment

Search the Technical Document Centre at http://telecominfo.telcordia.com

Some EMC testing references

continued...

EMC Testing (in seven parts), Tim Williams and Keith Armstrong, EMC & Compliance Journal 2001-2, www.compliance-club.com/KeithArmstrongPortfolio

This series is based on the IEC 61000-4-x basic test methods, but it also describes 'do-it-yourself' methods which have a variety of uses. E.g. it describes close-field probing methods which can be used check gaskets and joints for 'EM leaks' when subjected to physical stresses.

- The IEC 61000-4-x series Basic immunity test methods for residential, commercial, industrial environments, from the bookstore at www.iec.ch
- Don't forget that using the IEC 61000-4-x series as they are is not recommended for proving a design is safe enough